Sheet <u>1</u> of <u>2</u>

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Te ROEMBER OF	Atty. Docket No. 1559A1	Serial No. 09/714,166
LIST OF CITATIONS BY APPLICANT (Use several sheets if necessary)	Applicant Paul A. Medwick et a	1.
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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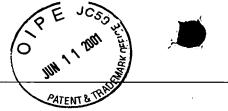
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